



## DESCRIPTION

The AM8958 is the N & P-Channel enhancement mode power field effect transistor using high cell density DMOS trench technology. This high density process is especially tailored to minimize on-state resistance and provide superior switching performance. This device is particularly suited for low voltage application such as notebook computer power management and other battery powered circuits, where high-side switching, low inline power loss and resistance to transient are needed.

The AM8958 is available in SOP8 Package

## ORDERING INFORMATION

| Package Type  | Part Number                        |            |
|---|------------------------------------|------------|
| SOP-8   | M8                                 | AM8958M8R  |
|   |                                    | AM8958M8VR |
| Note  | R: Tape & Reel<br>V: Green Package |            |
| AiT provides all Pb free products<br>Suffix " V " means Green Package |                                    |            |

## FEATURES

### N-Channel

- 30V / 6.8A,  $R_{DS(ON)} = 23m\Omega$ (typ.)@ $V_{GS} = 10V$
- 30V / 6.5A,  $R_{DS(ON)} = 34m\Omega$ (typ.)@ $V_{GS} = 4.5V$

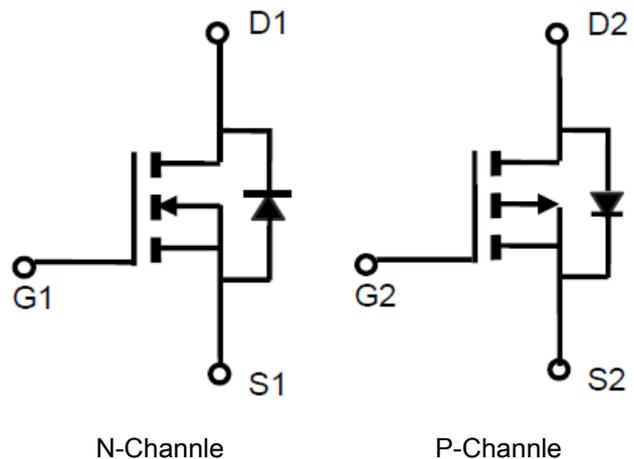
### P-Channel

- -30V / -6.5A,  $R_{DS(ON)} = 35m\Omega$ (typ.)@ $V_{GS} = -10V$
- -30V / -4.4A,  $R_{DS(ON)} = 60m\Omega$ (typ.)@ $V_{GS} = -4.5V$
- Super high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and Maximum DC current capability
- Available in SOP8 Package

## APPLICATION

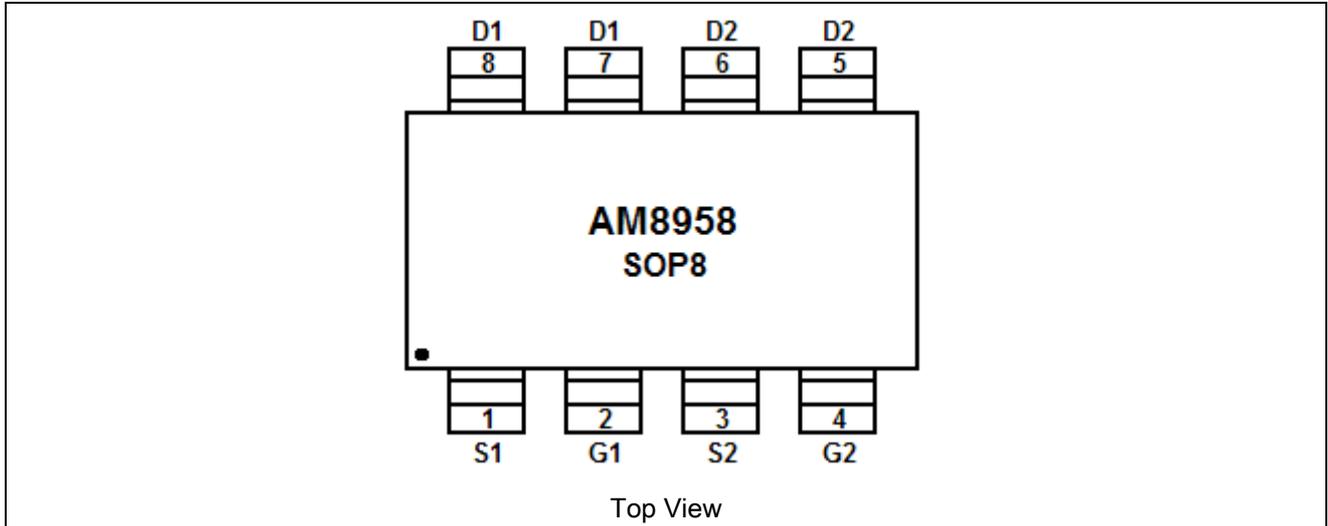
- Power Management in Note book
- Portable Equipment
- Battery Powered System

## P-CHANNEL MOSFET





## PIN DESCRIPTION



| Pin # | Symbol | Function |
|-------|--------|----------|
| 1     | S1     | Source1  |
| 2     | G1     | Gate1    |
| 3     | S2     | Source2  |
| 4     | G2     | Gate2    |
| 5     | D2     | Drain2   |
| 6     | D2     | Drain2   |
| 7     | D1     | Drain1   |
| 8     | D1     | Drain1   |



## ABSOLUTE MAXIMUM RATINGS

T<sub>A</sub> = 25°C Unless otherwise specified

| Symbol           | Parameter   | Typical |      | Unit |
|------------------|---|---------|------|------|
|                  |   | N       | P    |      |
| V <sub>DSS</sub> | Drain-Source Voltage  | 30      | -30  | V    |
| V <sub>GSS</sub> | Gate-Source Voltage   | ±20     | ±20  | V    |
| I <sub>D</sub>   | Continuous Drain Current (T <sub>J</sub> =150°C) T <sub>A</sub> =25°C | 6.8     | -6.5 | A    |
| I <sub>DM</sub>  | Pulsed Drain Current  | 25      | -25  | A    |
| I <sub>S</sub>   | Continuous Source Current (Diode Conduction)                          | 2.3     | -2.3 | A    |
| P <sub>D</sub>   | Power Dissipation   |         |      |      |
|                  | T <sub>A</sub> =25°C  | 2.5     | 2.8  | W    |
|                  | T <sub>A</sub> =70°C  | 1.6     | 1.8  | W    |
| T <sub>J</sub>   | Operation Junction Temperature  | 150     |      | °C   |
| T <sub>STG</sub> | Storage Temperature Range   | -55~150 |      | °C   |

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## THERMAL INFORMATION

| Parameter                              | Symbol           | Min | Typ | Max | Unit |
|--|------------------|-----|-----|-----|------|
| Thermal Resistance-Junction to Ambient | R <sub>θJA</sub> | 50  | -   | 80  | °C/W |



## ELECTRICAL CHARACTERISTICS

T<sub>A</sub> = 25°C Unless otherwise specified

| Parameter                       | Symbol               | Conditions   | Min | Typ  | Max  | Unit |    |
|---------------------------------|----------------------|--|-----|------|------|------|----|
| Drain-Source Breakdown Voltage  | V <sub>(BR)DSS</sub> | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA               | N   | 30   | -    | -    | V  |
|                                 |                      | V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA              | P   | -30  | -    | -    |    |
| Gate Threshold Voltage          | V <sub>GS(th)</sub>  | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA | N   | 1.0  | -    | -2.5 | V  |
|                                 |                      |  | P   | -1.0 | -    | -2.5 |    |
| Gate Leakage Current            | I <sub>GSS</sub>     | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V               | N   | -    | -    | ±100 | nA |
|                                 |                      |  | P   | -    | -    | ±100 |    |
| Zero Gate Voltage Drain Current | I <sub>DSS</sub>     | V <sub>DS</sub> =24V, V <sub>GS</sub> =0V                | N   | -    | -    | 1    | μA |
|                                 |                      |  | P   | -    | -    | -1   |    |
|                                 |                      |  | N   | -    | -    | 30   |    |
|                                 |                      |  | P   | -    | -    | -30  |    |
| On-State Drain Current          | I <sub>D(ON)</sub>   | V <sub>DS</sub> ≥5V, V <sub>GS</sub> =10V                | N   | 30   | -    | -    | A  |
|                                 |                      | V <sub>DS</sub> ≤-5V, V <sub>GS</sub> =-10V              | P   | -30  | -    | -    |    |
| Drain-source On-Resistance      | R <sub>DS(ON)</sub>  | V <sub>GS</sub> =10V, I <sub>D</sub> =6.8A               | N   | -    | 23   | 30   | mΩ |
|                                 |                      |  | P   | -    | 35   | 50   |    |
|                                 |                      |  | N   | -    | 34   | 42   |    |
|                                 |                      |  | P   | -    | 60   | 85   |    |
| <b>Source-Drain Diode</b>       |                      |  |     |      |      |      |    |
| Diode Forward Voltage           | V <sub>SD</sub>      | I <sub>S</sub> =1.7A, V <sub>GS</sub> =0V                | N   | -    | 0.7  | 1.2  | V  |
|                                 |                      | I <sub>S</sub> =-1.7A, V <sub>GS</sub> =0V               | P   | -    | -0.7 | -1.2 |    |
| <b>Dynamic Parameters</b>       |                      |  |     |      |      |      |    |
| Total Gate Charge               | Q <sub>g</sub>       | N-Channel<br>V <sub>DS</sub> =15V, V <sub>GS</sub> =10V  | N   | -    | 13   | 20   | nC |
|                                 |                      |  | P   | -    | 15   | 25   |    |
| Gate-Source Charge              | Q <sub>GS</sub>      | I <sub>D</sub> =6.0A                                     | N   | -    | 2.3  | -    | nC |
|                                 |                      |  | P   | -    | 4.0  | -    |    |
| Gate-Drain Charge               | Q <sub>GD</sub>      | V <sub>DS</sub> =-15V, V <sub>GS</sub> =-10V             | N   | -    | 2.0  | -    | nC |
|                                 |                      |  | P   | -    | 2.0  | -    |    |
| Turn-On Time                    | t <sub>d(on)</sub>   | N-Channel<br>V <sub>DD</sub> =15V, R <sub>L</sub> =150Ω  | N   | -    | 6.0  | 12   | nS |
|                                 |                      |  | P   | -    | 7.0  | 15   |    |
|                                 | T <sub>r</sub>       | I <sub>D</sub> =1.0A, V <sub>GEN</sub> =10V              | N   | -    | 14   | 25   |    |
|                                 |                      |  | P   | -    | 10   | 20   |    |
| Turn-Off Time                   | t <sub>d(off)</sub>  | P-Channel<br>V <sub>DD</sub> =-15V, R <sub>L</sub> =150Ω | N   | -    | 30   | 60   | nS |
|                                 |                      |  | P   | -    | 40   | 80   |    |
|                                 | T <sub>f</sub>       | I <sub>D</sub> =-1.0A, V <sub>GEN</sub> =-10V            | N   | -    | 5    | 10   |    |
|                                 |                      |  | P   | -    | 20   | 40   |    |

NOTE: 1. Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%

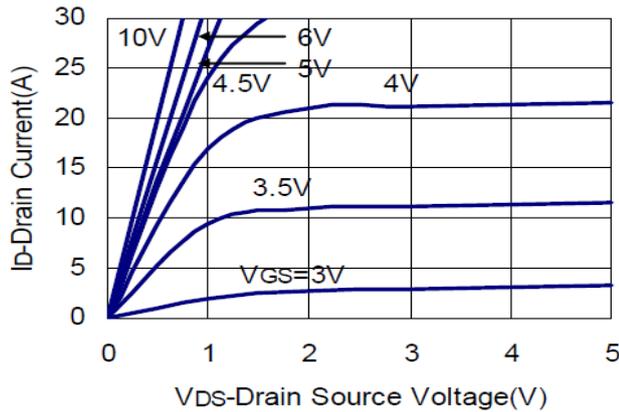
2. Static parameters are based on package level with recommended wire-bonding



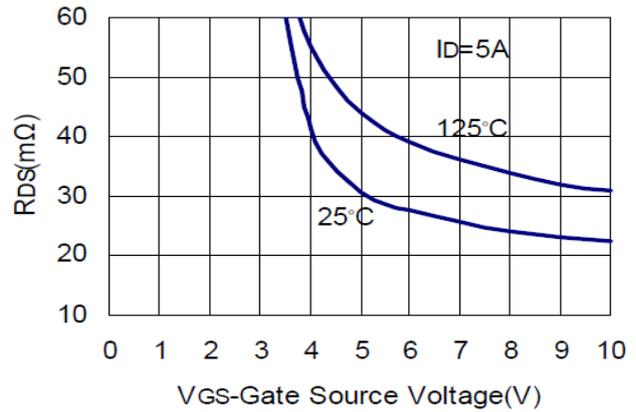
## TYPICAL CHARACTERISTICS

### N-Channel

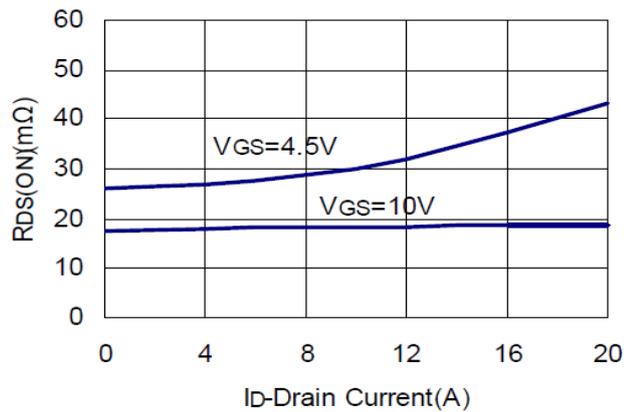
#### 1. Output Characteristics



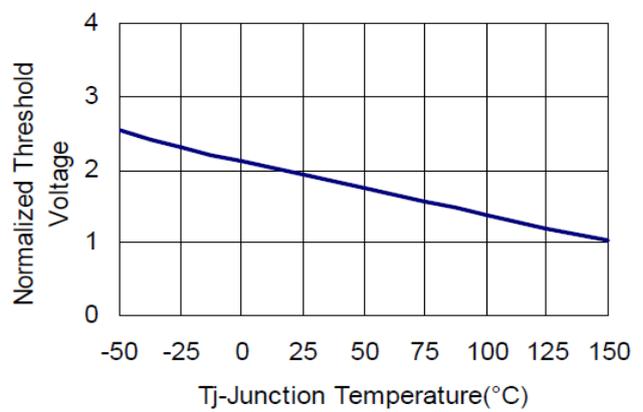
#### 2. Drain Source On Resistance



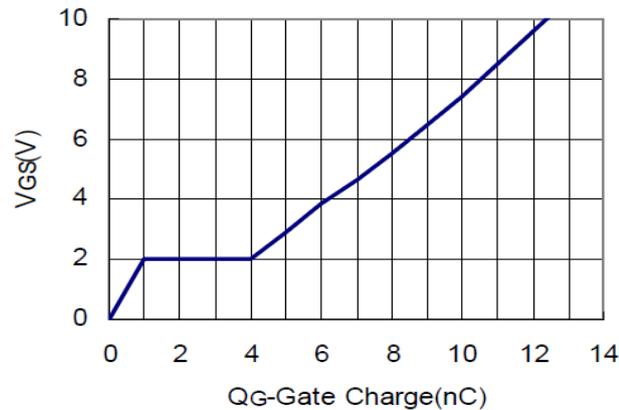
#### 3. Drain Source On Resistance



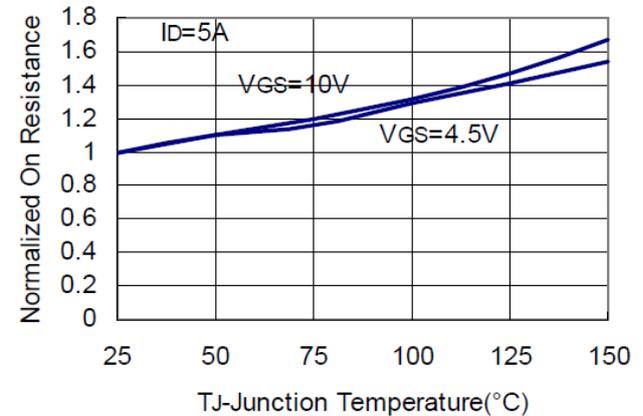
#### 4. Gate Threshold Voltage



#### 5. Gate Charge

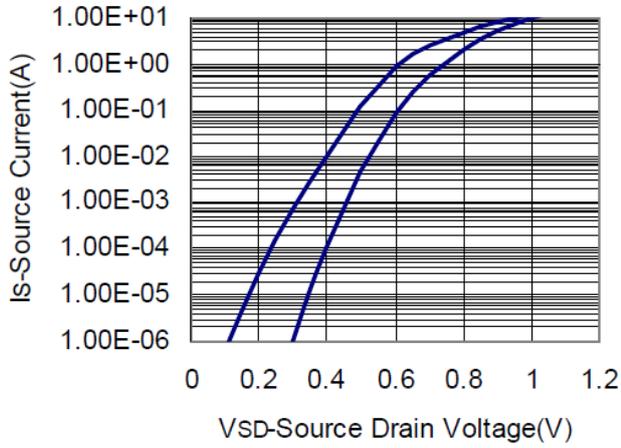


#### 6. Drain Source On Resistance

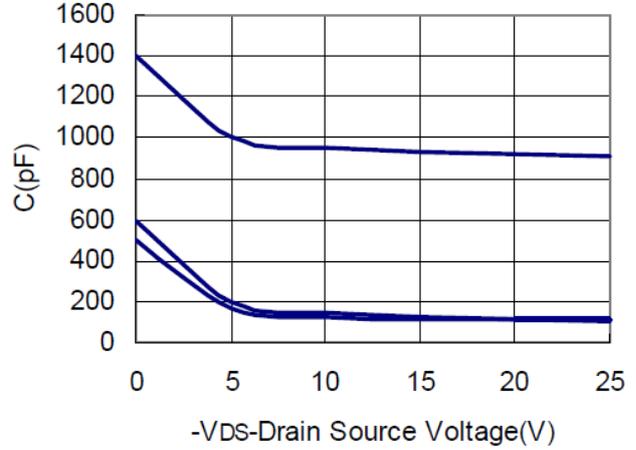




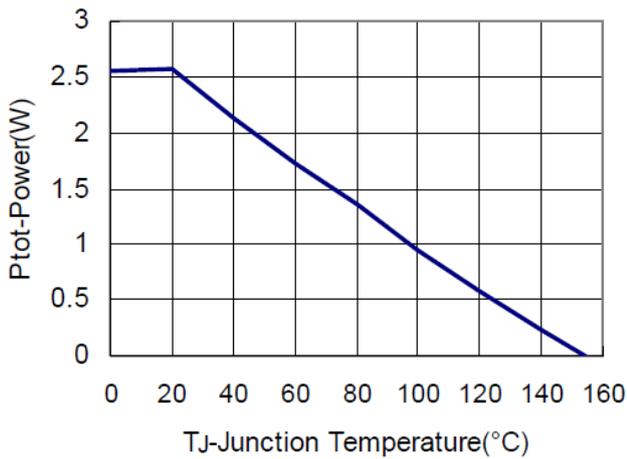
7. Source Drain Diode Forward



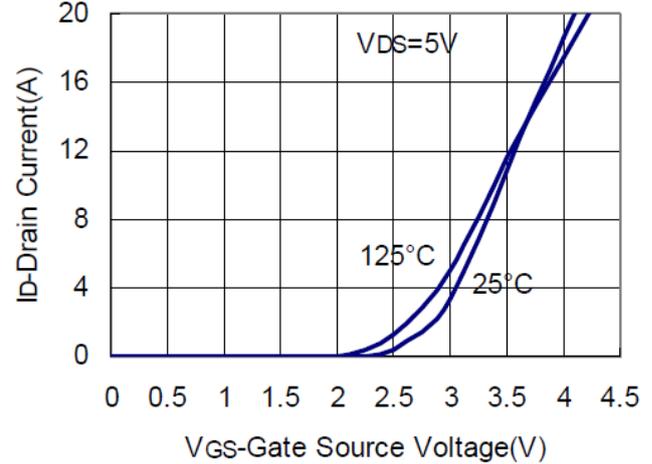
8. Capacitance



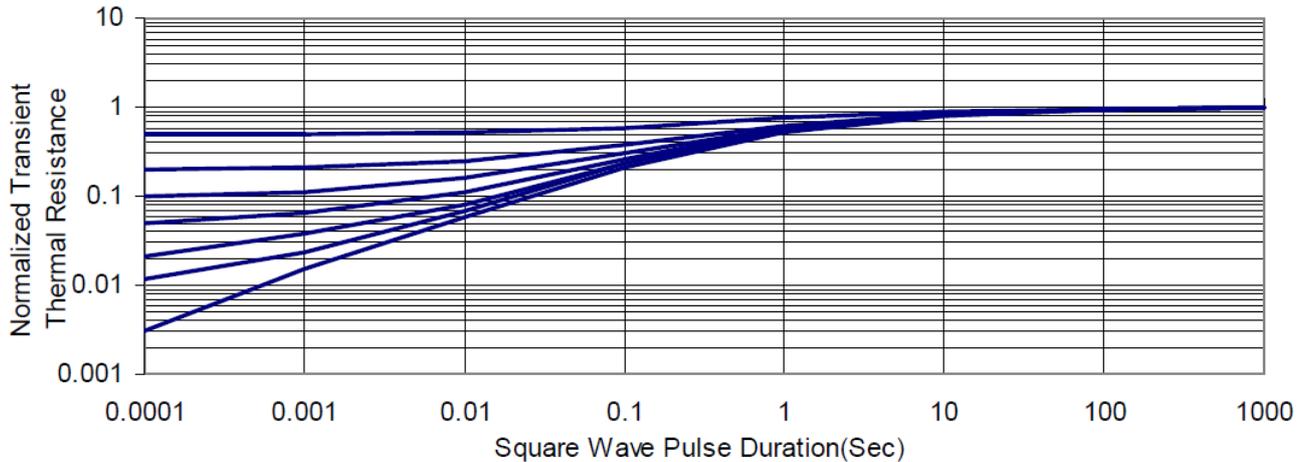
9. Power Dissipation



10. Drain Current



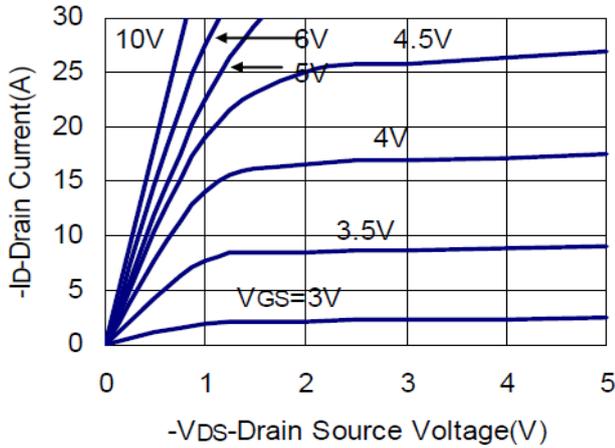
11. Thermal Transient Impedance



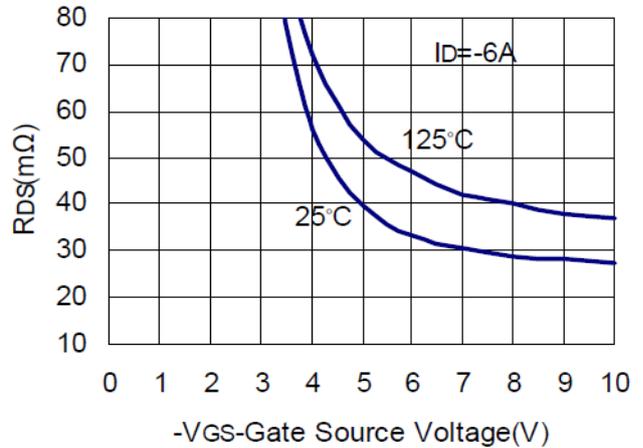


**P-Channel**

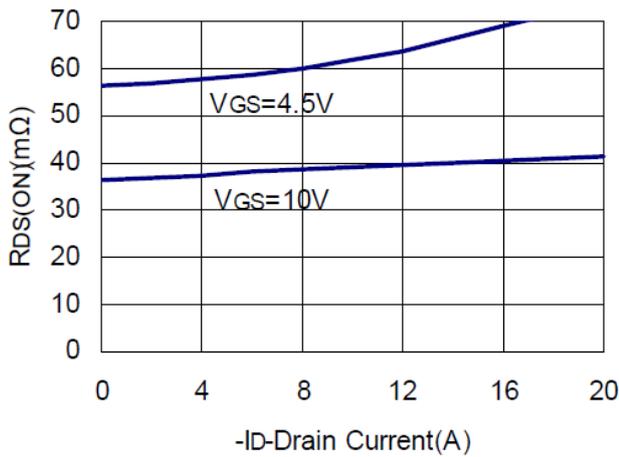
12. Output Characteristics



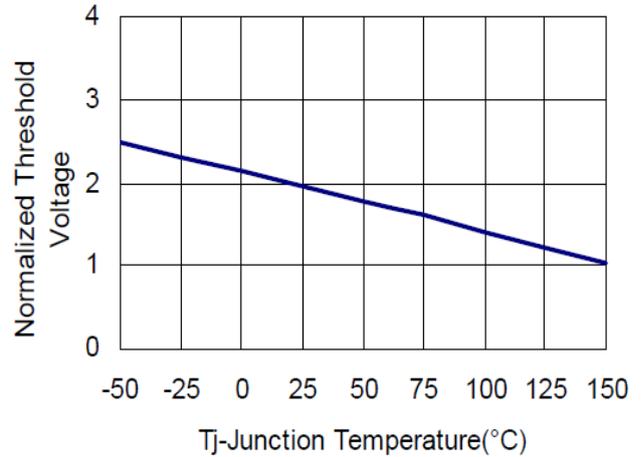
13. Drain Source On Resistance



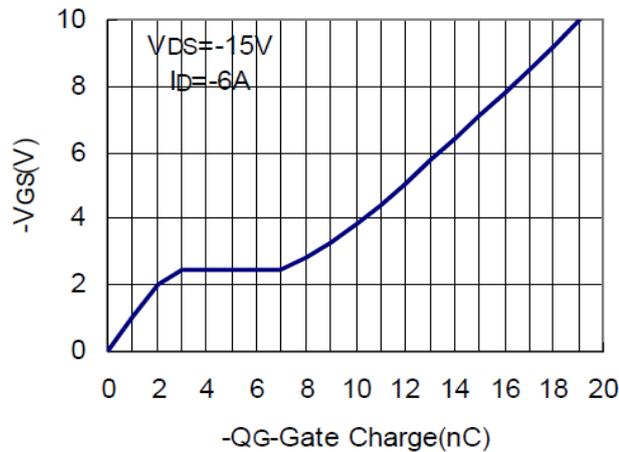
14. Drain Source On Resistance



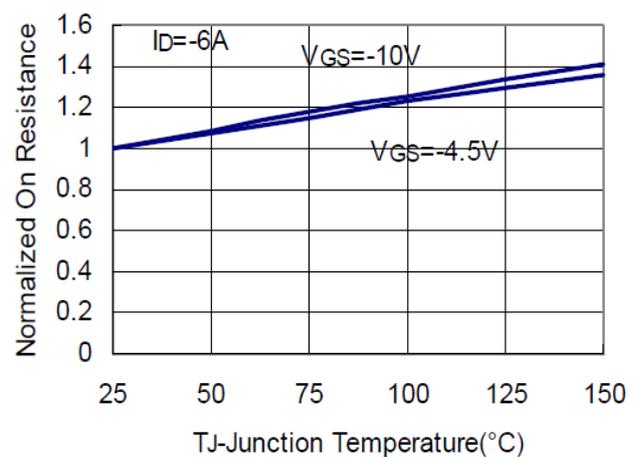
15. Gate Threshold Voltage



16. Gate Charge

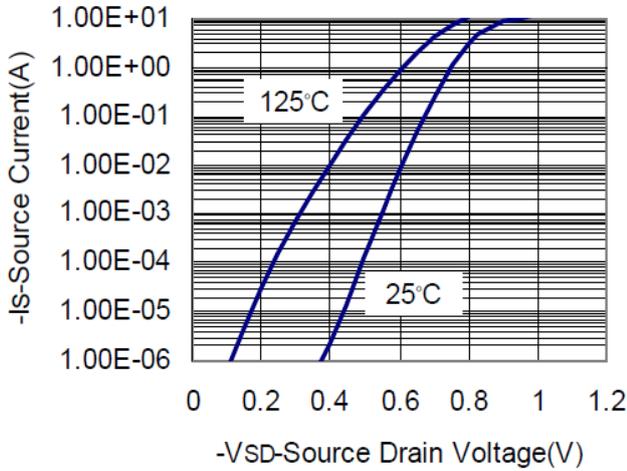


17. Drain Source On Resistance

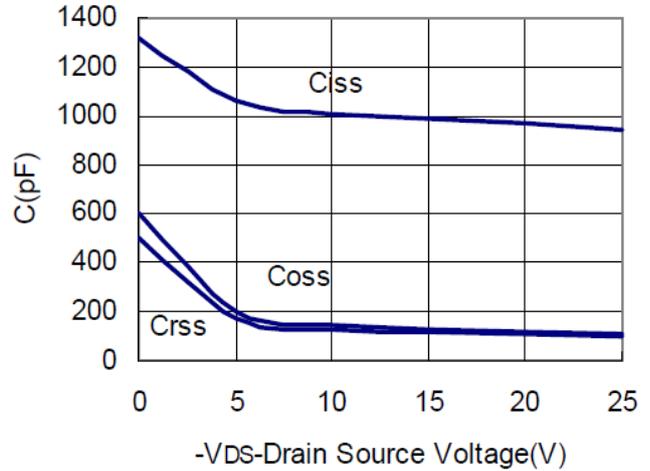




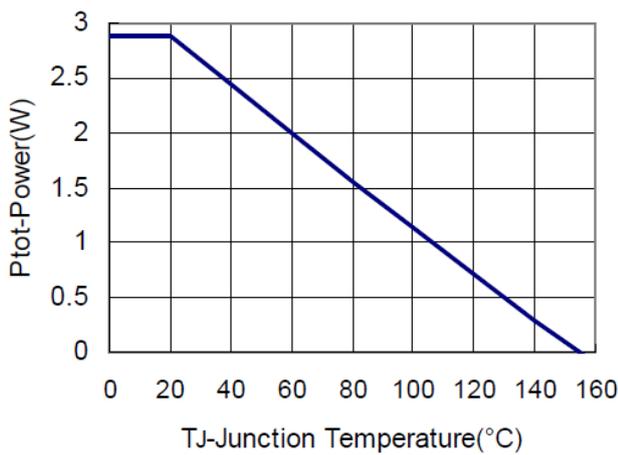
18. Source Drain Diode Forward



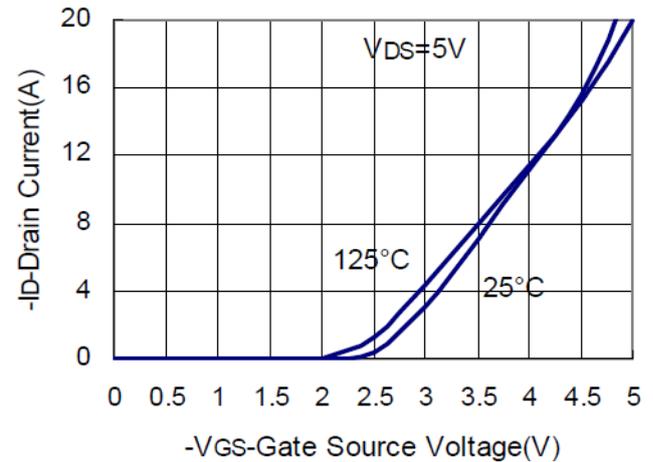
19. Capacitance



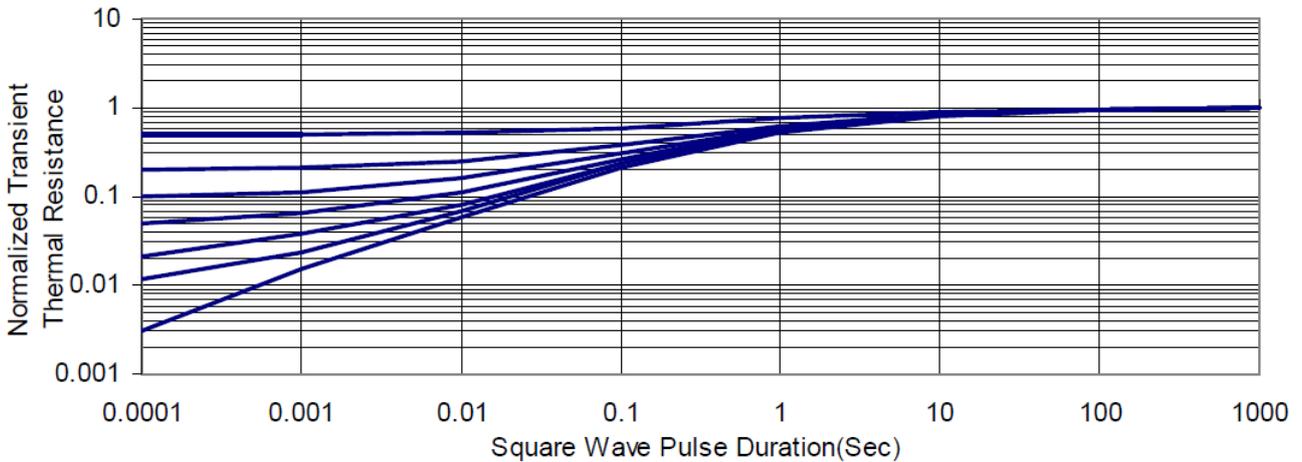
20. Power Dissipation



21. Drain Current



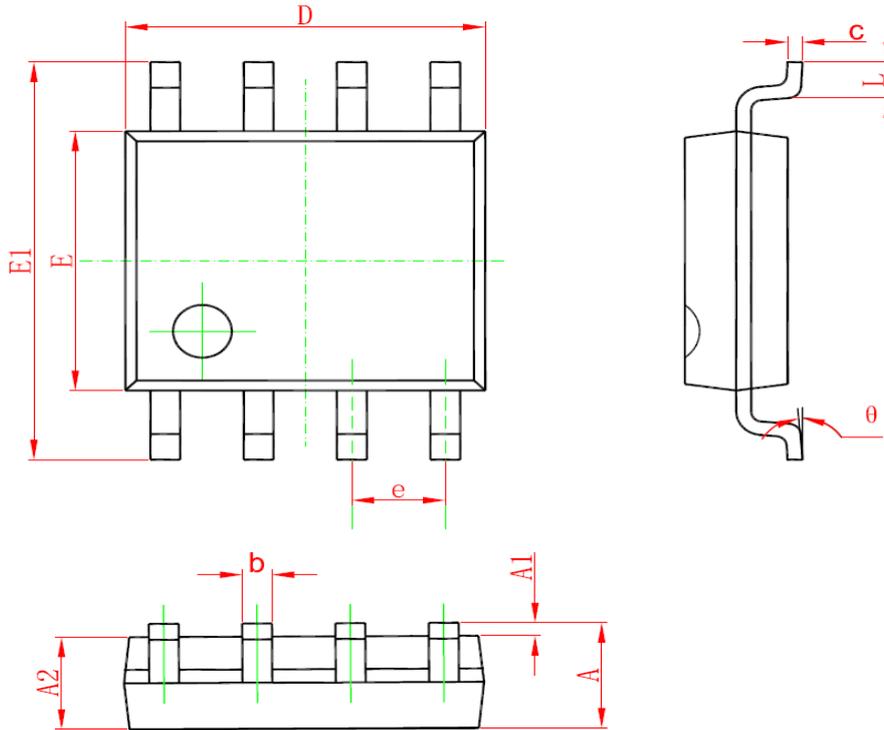
22. Thermal Transient Impedance





## PACKAGE INFORMATION

Dimension in SOP-8 (Unit: mm)



| Symbol   | Min        | Max   |
|----------|------------|-------|
| A        | 1.350      | 1.750 |
| A1       | 0.100      | 0.250 |
| A2       | 1.350      | 1.550 |
| b        | 0.330      | 0.510 |
| c        | 0.170      | 0.250 |
| D        | 4.700      | 5.100 |
| E        | 3.800      | 4.000 |
| E1       | 5.800      | 6.200 |
| e        | 1.270(BSC) |       |
| L        | 0.400      | 1.270 |
| $\theta$ | 0°         | 8°    |



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